


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/818,715	LEE ET AL.	
	Examiner	Art Unit	
	Thu V. Huynh	2178	

SEARCHED			
Class	Subclass	Date	Examiner
Update	Search	8/2/2007	TVH
715	513, 523	8/2/2007	TVH
715	530	8/2/2007	TVH
705	2-3	8/2/2007	TVH
707	1, 102	8/2/2007	TVH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PGPUB, USPAT, JPO, EPO, DERWENT, IBM_TDB) See Search History Printout	8/2/2007	TVH